

# SIDC81D120H8

## Fast switching diode chip in Emitter Controlled Technology

#### Features:

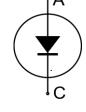
- 1200V Emitter Controlled technology 120 µm chip
- Soft, fast switching
- Low reverse recovery charge
- Small temperature coefficient
- Qualified according to JEDEC for target applications

### **Recommended for:**

Power modules and discrete devices

### **Applications:**

• SMPS, resonant applications, drives



Chip Type	V <sub>R</sub>	<b>I</b> Fn	Die Size	Package
SIDC81D120H8	1200V	150A	9 x 9 mm <sup>2</sup>	sawn on foil

### **Mechanical Parameters**

Die size		9 x 9			
Area total		81	mm²		
Anode pad size		8.046 x 8.046			
Thickness		120	μm		
Wafer size		200	mm		
Max. possible chips pe	er wafer	315	315		
Passivation frontside		Photoimide			
Pad metal		3200 nm AlSiCu			
Backside metal		Ni Ag – system To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process			
Die bond		Electrically conductive epoxy glue and soft solder			
Wire bond		AI, $\leq$ 500 $\mu$ m			
Reject ink dot size		Ø 0.65 mm; max 1.2 mm			
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17 °C – 25 °C, < 6 months			
	for open MBB bags	Acc. to IEC62258-3: Atmosphere > 99% Nitrogen or inert gas, Humidity < 25% RH, Temperature 17 °C – 25 °C, < 6 months			



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#### **Maximum Ratings**

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V <sub>RRM</sub>	<i>T</i> <sub>vj</sub> = 25 °C	1200	V
Continuous forward current	I <sub>F</sub>	<i>T</i> <sub>νj</sub> < 150 °C	1)	^
Maximum repetitive forward current <sup>2)</sup>	I <sub>FRM</sub>	<i>T</i> <sub>νj</sub> < 150 °C	300	A
Junction temperature range	T <sub>vj</sub>		-40+175	°C
Operating junction temperature	T <sub>vj</sub>		-40+150	°C

<sup>1)</sup> depending on thermal properties of assembly

<sup>2)</sup> not subject to production test - verified by design/characterisation

## Static Characteristics (tested on wafer), $T_{vj} = 25 \text{ °C}$

Parameter	Symbol	Condition	Value			Unit
Faidillelei		Condition	min.	typ.	max.	Unit
Reverse leakage current	I <sub>R</sub>	$V_{\rm R} = 1200 {\rm V}$			27	μA
Cathode-Anode breakdown voltage	V <sub>BR</sub>	$I_{\rm R} = 0.25 {\rm mA}$	1200			V
Forward voltage drop	V <sub>F</sub>	$I_{\rm F} = 45 \rm A$	1.06	1.29	1.41	

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter		Symbol Condition	Condition	Value			Unit
			min.	typ.	max.	Unit	
Forward voltage	<i>T</i> <sub>vj</sub> = 25 °C	V	1 - 1504		1.65	2.15	V
drop	<i>T</i> <sub>vj</sub> = 150 °C	V <sub>F</sub>	I <sub>F</sub> = 150A		1.65		V

### **Further Electrical Characteristics**

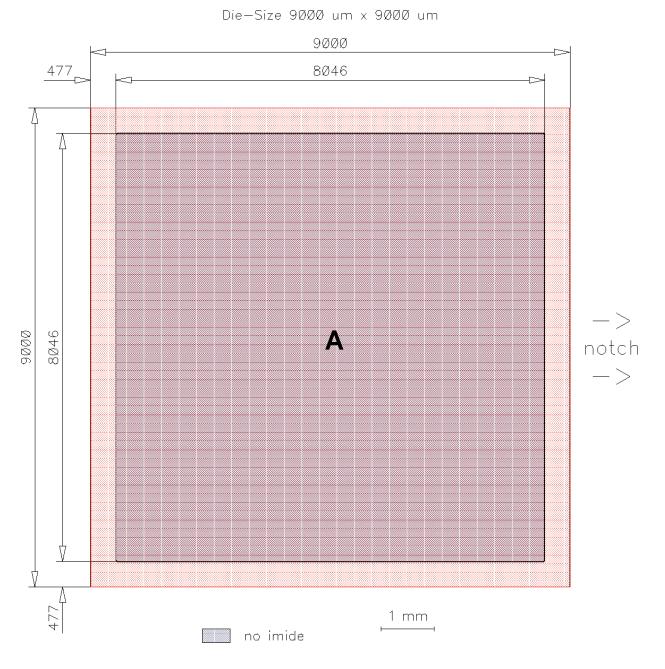
Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FS150R12KE3	Rev. 3.1, 02.10.2013
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## Chip Drawing



A: Anode pad



#### **Bare Die Product Specifics**

Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

### Description

AQL 0.65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

#### **Revision History**

Version	Subject (major changes since last revision)	Date
2.0	Final data sheet	30.12.2014
2.1	Editorial changes	14.10.2015





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